

<Full SiC Power Modules>

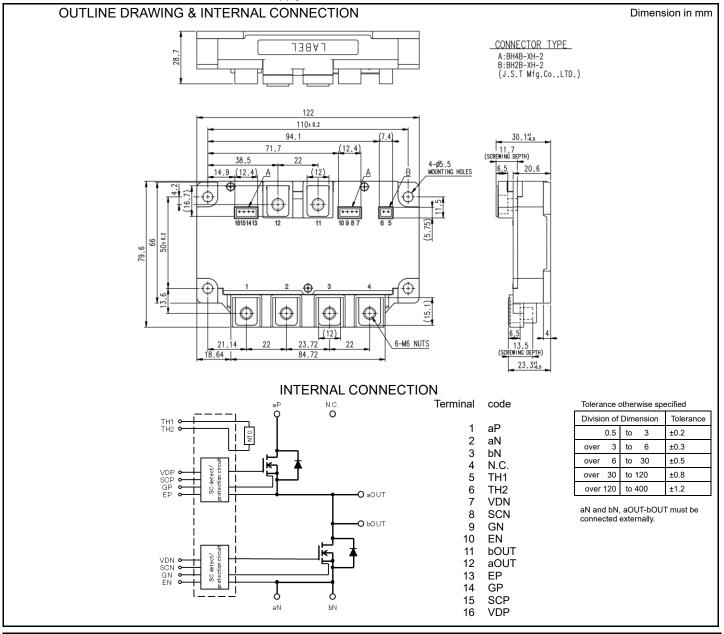
FMF300DXZ-34B

HIGH POWER SWITCHING USE INSULATED TYPE

and the second second	Drain current I _D 300 A
E .	Drain-Source voltage V _{DSX} 1 7 0 0 V
	Maximum junction temperature T _{vjmax} 175 °C
	 Silicon Carbide MOSFET + Silicon Carbide Schottky Barrier Diode
H	●Flat base Type
and an and the second	•Copper base plate
	RoHS Directive compliant
Dual switch (Half-Bridge)	 Recognized under UL1557, File E323585

APPLICATION

AC Motor Control, Motion/Servo Control, Power supply, etc.



MITSUBISHI ELECTRIC CORPORATION

<Full SiC Power Modules> FMF300DXZ-34B HIGH POWER SWITCHING USE INSULATED TYPE

MAXIMUM RATINGS (T_{vj} =25 °C, unless otherwise specified)

Symbol	Item	Conditions	Rating	Unit
V _{DSX}	Drain-source voltage	V _{GS} =-15 V	1700	V
V _{GSS}	Gate-source voltage	D-S short-circuited	±20	V
ID	Ducin comment	DC, T _c =48°C ^(Note.2)	300	•
I _{DRM}	Drain current	Pulse, Repetitive ^(Note.3) , T _{vj} =150°C	450	A
P _{tot}	Total power dissipation	Tc=25 °C (Note. 2)	1230	W
Is (Note.1)	Course ourset	DC	300	•
I _{SRM} (Note.1)	Source current	Pulse, Repetitive ^(Note.3) , T _{vj} =150°C	450	A
Visol	Isolation voltage	Terminals to base plate, RMS, f=60 Hz, AC 1 min	5000	V
T _{vjmax}	Maximum junction temperature	Instantaneous event (overload) (Note.10)	175	°C
Tvjop	Operating junction temperature	Continuous oepration (under switching) (Note.10)	-40~+150	°C
T _{cmax}	Maximum case temperature	(Note.2, 10)	125	°C
T _{stg}	Storage temperature	-	-40~+125	°C

ELECTRICAL CHARACTERISTICS (Tvj=25 °C, unless otherwise specified)

Symbol	ltem	Conditions (note9)		Limits		Unit
Symbol	Item	Conditions	,	Min.	Тур.	Max.	Unit
I	Drain-source cut-off current	V _{DS} =V _{DSX} , V _{GS} =-15 V		-	-	5	mA
IDSX	Drain-source cut-oil current	V _{DS} =1000V, V _{GS} =-15 V		-	-	0.5	mA
$V_{GS(th)}$	Gate-source threshold voltage	I _D =113 mA, V _{DS} =10 V		1.8	2.5	3.2	V
I _{GSS}	Gate-source leakage current	V _{GS} =V _{GSS} , D-S short-circuited		-	-	0.5	μA
.,			T _{vj} =25 °C	-	1.65	2.60	
V _{DS(on)} (terminal)	Drain-source on-state voltage	I_D =300 A, V_{GS} =15V (Note.6)	T _{vj} =125 °C	-	2.19	-	V
(terminal)			T _{vj} =150 °C	-	2.33	-	
			T _{vj} =25 °C	-	1.47	-	
V _{DS(on)}	Drain-source on-state voltage	I_D =300 A, V_{GS} =15V (Note.6)	T _{vj} =125 °C	-	2.01	1 -	V
(chip)			T _{vj} =150 °C	-	2.15	-	
			T _{vj} =25 °C	-	4.90	-	
r _{DS(on)}	Drain-source on-state resistance	istance I _D =300 A, V _{GS} =15V ^(Note.6)	T _{vj} =125 °C	-	6.70	-	mΩ
(chip)			T _{vj} =150 °C	-	7.16	-	
Ciss	Input capacitance				27.4	-	
Coss	Output capacitance	V _{DS} =10 V, V _{GS} =0V		-	17	-	nF
Crss	Reverse transfer capacitance			-	0.98	-	
Q_{G}	Gate charge	V _{DD} =900 V, I _D =300 A, V _{GS} =0→15	V	-	800	-	nC
t _{d(on)}	Turn-on delay time			-	200	-	- ns
tr	Rise time			-	50	-	
t _{d(off)}	Turn-off delay time			-	220	-	
t _f	Fall time	V _{DD} =900 V, I _D =300 A, V _{GS} =±15 V, R _G =1.5Ω, L _{s ext} =16nH, Inductive Iα		-	30	-	
Eon	Turn-on switching energy	-1.322 , $L_{s_{ext}}$ - 10111, inductive it	bau, per puise	-	16	-	
E _{off}	Turn-off switching energy			-	5	-	mJ
Qc	Drain-source charge			-	3.8	-	μC
			T _{vj} =25 °C	-	1.80	2.40	
$V_{\text{SD}} \ ^{(\text{Note.1})}$	Source-drain voltage	I _S =300 A ^(Note.6) V _{GS} =-15 V	T _{vj} =125 °C	-	2.45	-	V
(terminal)		VGS13 V	T _{vi} =150 °C	-	2.69	-	
		T _{vj} =25 °C	-	1.64	-		
V _{SD} (Note.1)	Source-drain voltage	$I_{s}=300 A^{(Note.6)}$	Is=300 A (^{Note.6)} V _{GS} =-15 V T _{vj} =125 °C	-	2.28	-	V
(chip)	-	VGS13 V	T _{vi} =150 °C	-	2.52	-	
R _{DD'+SS'}	Internal lead resistance	aP-EP, OUT-EN terminals, per sv		-	0.6	-	mΩ
Ls	Internal stray inductance	P-N		-	25	-	nH
r _g	Internal gate resistance	Per switch		-	0.5	-	Ω

HIGH POWER SWITCHING USE INSULATED TYPE

THERMAL RESISTANCE CHARACTERISTICS

Cumphical	Symbol Item	Conditions	Limits			Linit
Symbol			Min.	Тур.	Max.	Unit
R _{th(j-c)Q}	Thermal resistance ^(Note. 2)	Junction to case, per inverter switch	-	-	121	K/kW
R _{th(j-c)D}		Junction to case, per inverter FWD	-	-	131	r\/KVV
R _{th(c-s)} Contact	Contact thermal resistance ^(Note.2)	Case to heat sink, per 1 module,		12		K/kW
	Contact thermal resistance	Thermal grease applied (Note.8, 10)	-		-	N/KVV

NTC THERMISTOR PART

Symbol Item	Itom	Conditions		Unit		
	item		Min.	Тур.	Max.	Unit
R ₂₅	Zero-power resistance	T _c =25 °C ^(Note.2)	4.85	5.00	5.15	kΩ
ΔR/R	Deviation of resistance	Tc=100 °C ^(Note.2) ,R ₁₀₀ =493 Ω	-7.3	-	+7.8	%
B _(25/50)	B-constant	Approximate by equation (Note.7)	-	3375	-	K
P ₂₅	Power dissipation	T _c =25 °C ^(Note.2)	-	-	10	mW

MECHANICAL CHARACTERISTICS

Symbol	ltem	Conditions			- Unit		
		Conditions	Conditions		Тур.	Max.	Unit
Mt	Mounting torque	Main terminals	M 6 screw	3.5	4.0	4.5	N
Ms		Mounting to heat sink	M 5 screw	2.5	3.0	6.0	N∙m
m	mass	-		-	500	-	g
da	Clearance			10	-	-	mm
ds	Creepage distance			17	-	-	mm
ec	Flatness of base plate	On the centerline X, Y (Note.5)		-100	-	+100	μm
-	Connector insertion force	2 pin type		0	-	25	Ν
		4 pin type		0	-	35	Ν

*: This product is compliant with the Restriction of the Use of Certain Hazardous Substances in Electrical and Electronic Equipment (RoHS) directive 2011/65/EU and (EU)2015/863.

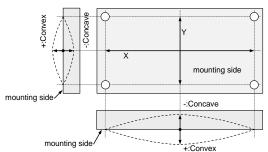
Note1. Represent ratings and characteristics of the anti-parallel, source-drain free wheeling diode (FWD).

2. Case temperature (T_c) and heat sink temperature (T_s) are defined on the each surface (mounting side) of base plate and heat sink just under the chips. Refer to the figure of chip location.

3. Pulse width and repetition rate should be such that the device junction temperature (T_{vj}) does not exceed T_{vjmax} rating.

4. Junction temperature (T_{vj}) should not increase beyond T_{vjmax} rating.

5. The base plate (mounting side) flatness measurement points (X, Y) are as follows of the following figure.



6. Pulse width and repetition rate should be such as to cause negligible temperature rise.

7. $B_{(25/50)} = ln(\frac{R_{25}}{R_{50}})/(\frac{1}{T_{25}} - \frac{1}{T_{50}})$

 $R_{25}{:}$ resistance at absolute temperature T_{25} [K]; $T_{25}{=}25$ [°C]+273.15=298.15 [K]

 $R_{50}{:}$ resistance at absolute temperature T_{50} [K]; $T_{50}{=}50$ [°C]+273.15=323.15 [K]

- 8. Typical value is measured by using thermally conductive grease of λ =0.9 W/(m·K)/D_(C-S)=100µm.
- 9. Per switch (ex. Tr1 chips total in page.6)
- 10. Long term performance related to thermal conductive grease (including but not limited to aspects such as the increase of thermal resistance due to pumping out, etc.) should be verified under your specific application conditions. Each temperature condition (T_{vj max}, T_{vj op}, T_{C max}) must be maintained below the maximum rated temperature throughout consideration of the temperature rise even for long term usage.

<Full SiC Power Modules> FMF300DXZ-34B HIGH POWER SWITCHING USE INSULATED TYPE

RECOMMENDED OPERATING CONDITIONS

Sympol	ltana Canditiana			1.1			
Symbol Item		Conditions		Min.	Тур.	Max.	Unit
V _{DD}	(DC) Supply voltage	Applied across aP -aN+bN terminals		-	900	1200	V
VD	DC supply voltage (control)	Applied across VDP-EP, VDN-EN terminals			15.0	16.5	V
V _{GS(+)}	Gate-Source positive drive voltage	Applied across GP-EP, GN-EN terminals		13.5	15.0	16.5	V
V _{GS(-)}	Gate-Source negative drive voltage	Applied across GP-EP, GN-EN terminals		-16.5	-15.0	-7.0	V
R _G	External gate resistance (Note.11)	Per switch	Per switch		-	7.5	Ω
£	Switching frequency	$V_{GS(+)}$ =15V, R _G =1.5 Ω , V _{DD} =900V,	V _{GS(-)} <-10V	-	-	50	kHz
I _C		T _{vj} =150°C	V _{GS(-)} ≧-10V	-	-	100	kHz
t _{d(SCoff)}	Gate cutoff delay time after SC output	V _{GS} =15V, R _G =1.5Ω, V _{DD} ≦1200V, T _{vj} =150°C		-	-	3	μs

Note 11. The value of external gate resistance should be considered the surge voltage not to exceed the rating voltage in the worst system condition.

SHORT CIRCUIT DETECTION & PROTECTION CHARACTERISTICS

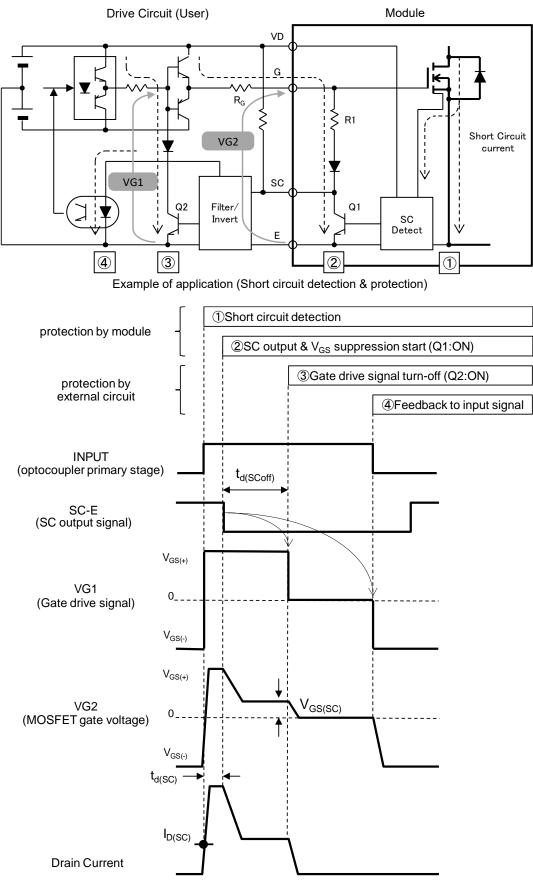
Symbol Item	Itom	Conditions		Unit		
	Item		Min.	Тур.	Max.	Unit
I _{D(SC)}	SC detect drain current	T _{vj} =150°C, V _{GS} =15V	450	600	-	Α
$t_{d(SC)}$	SC detect delay time	T_{vj} =150°C, $V_{DD} \leq 1200V$, V_{GS} =15V, R_G =1.5 Ω	-	1	-	μs
$V_{GS(SC)}$	SC protection gate limit voltage	T_{vj} =150°C, V _{GS} =15V, R _G =1.5 Ω	-	0	-	V
R1	SC protection gate limit resistance	-	-	0	-	Ω

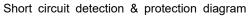
Refer to the circuit in page.5

HIGH POWER SWITCHING USE

INSULATED TYPE

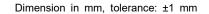
SHORT CIRCUIT DETECTION & PROTECTION

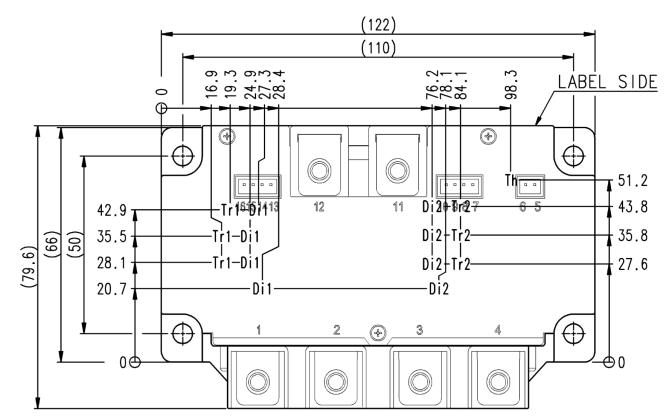




HIGH POWER SWITCHING USE INSULATED TYPE

CHIP LOCATION (Top view)

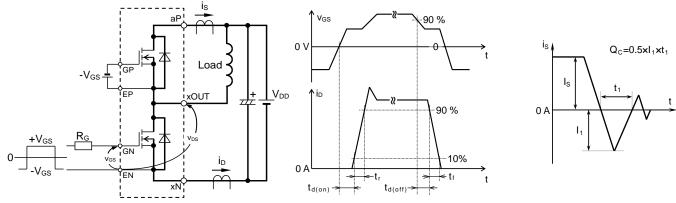




Tr1,Tr2: SiC-MOSFET, Di1,Di2: SiC-SBD, Th: NTC thermistor

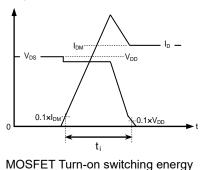
HIGH POWER SWITCHING USE **INSULATED TYPE**

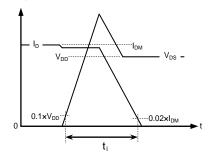
TEST CIRCUIT AND WAVEFORMS



Switching characteristics test circuit and waveforms(x: connected a* and b*)

Qc test waveform





MOSFET Turn-off switching energy

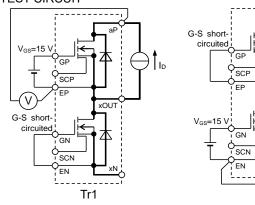
Turn-on / Turn-off switching energy test waveforms (Integral time instruction drawing)

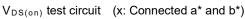
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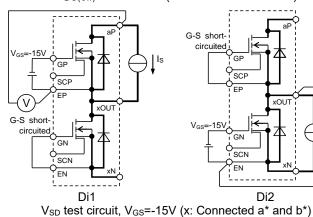
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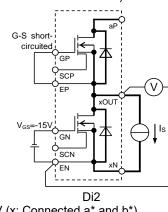
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TEST CIRCUIT

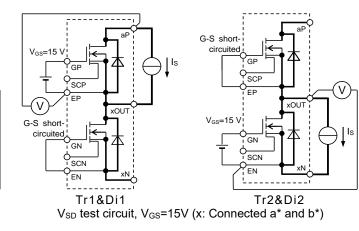






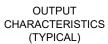


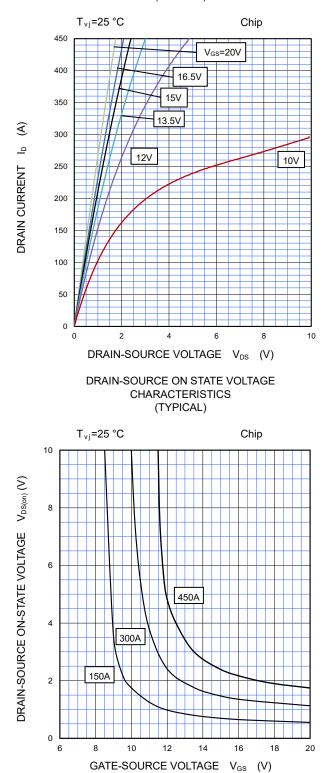
Tr2

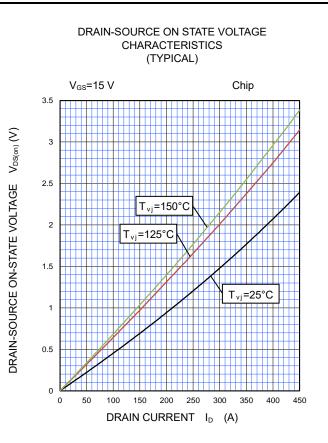


HIGH POWER SWITCHING USE INSULATED TYPE

PERFORMANCE CURVES

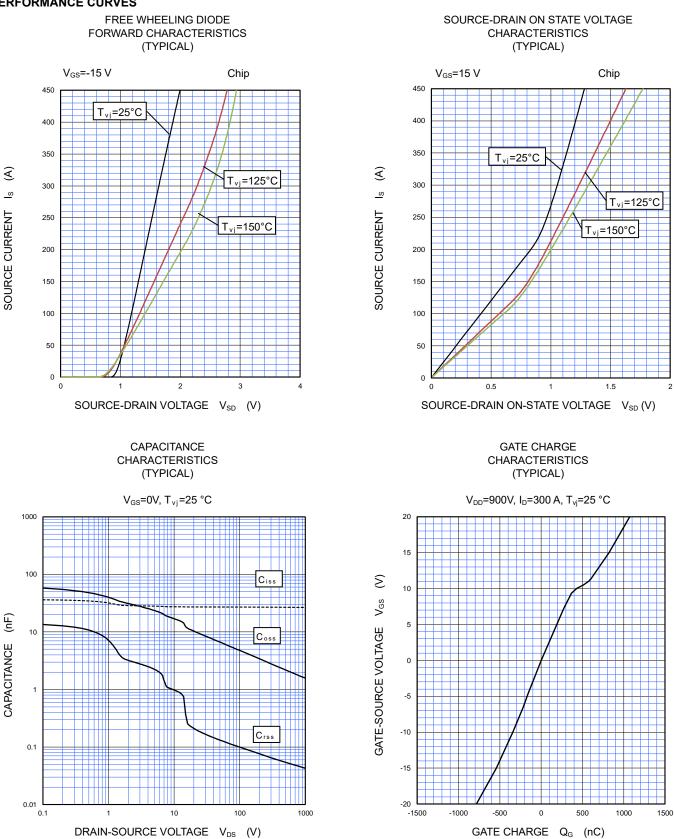






HIGH POWER SWITCHING USE INSULATED TYPE

PERFORMANCE CURVES

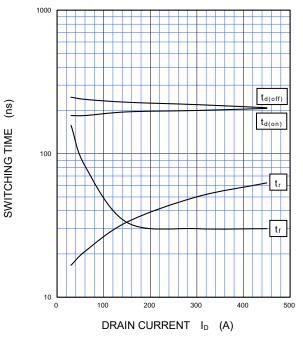


HIGH POWER SWITCHING USE INSULATED TYPE

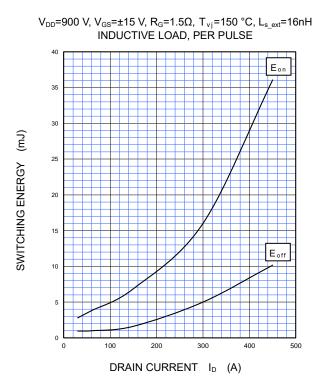
PERFORMANCE CURVES

HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

 $V_{\text{DD}}\text{=900 V, V}_{\text{GS}}\text{=}\pm15 \text{ V, R}_{\text{G}}\text{=}1.5 \ \Omega, \ T_{\text{vj}}\text{=}150 \ ^{\circ}\text{C}, \ L_{\text{s_ext}}\text{=}16\text{nH}$ INDUCTIVE LOAD, PER PULSE

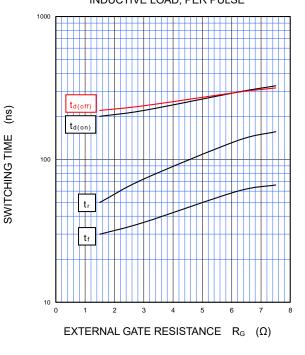


HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)



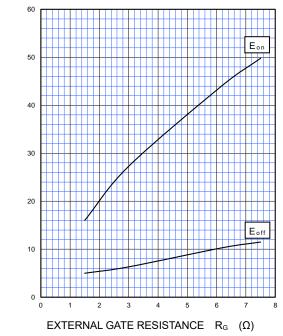
HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

 $V_{\text{DD}}\text{=}900 \text{ V}, \text{ } V_{\text{GS}}\text{=}\pm15 \text{ } \text{V}, \text{ } \text{I}_{\text{D}}\text{=}300 \text{ } \text{A}, \text{ } \text{T}_{\text{vj}}\text{=}150 \text{ }^{\circ}\text{C}, \text{ } \text{L}_{\text{s}_\text{ext}}\text{=}16\text{nH}$ INDUCTIVE LOAD, PER PULSE



HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

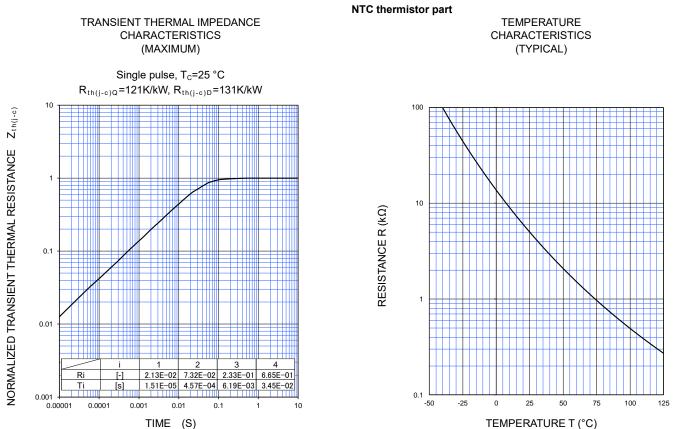
 $V_{\text{DD}}\text{=}900$ V, $V_{\text{GS}}\text{=}\pm15$ V, $I_{\text{D}}\text{=}300$ A, $T_{\text{vj}}\text{=}150$ °C, $L_{\text{s_ext}}\text{=}16\text{nH}$ INDUCTIVE LOAD, PER PULSE



(Lm)

SWITCHING ENERGY

PERFORMANCE CURVES



Note: The characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.

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